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Status	Product Specification

FAST Products

FAST 74F640

Transceiver

Octal Bus Transceiver , Inverting (3-State)

FEATURES

- High-impedance NPN base inputs for reduced loading ($70\mu A$ in High and Low states)
- Ideal for applications which require high-output drive and minimal bus loading
- Inverting version of 'F245
- Octal bidirectional bus interface
- 3-state buffer outputs sink $64mA$ and source $15mA$

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F640	3.5ns	78mA

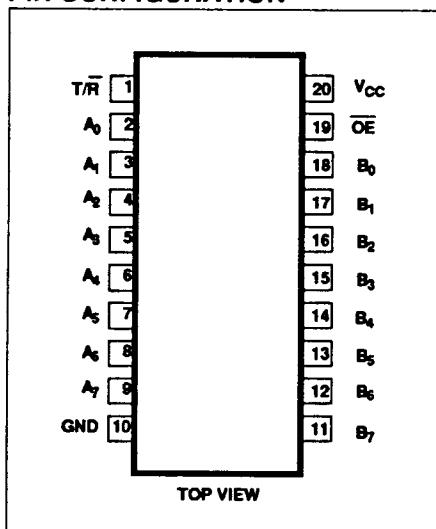
ORDERING INFORMATION

PACKAGES	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$; $T_A = 0^\circ C$ to $+70^\circ C$
20-Pin Plastic DIP	N74F640N
20-Pin Plastic SOL	N74F640D

DESCRIPTION

The 74F640 is an octal transceiver featuring inverting 3-state bus compatible outputs in both transmit and receive directions. The B port outputs are capable of sinking $64mA$ and sourcing $15mA$, providing very good capacitive drive characteristics. The device features an Output Enable (\overline{OE}) input for easy cascading and Transmit/Receive(T/R) input for direction control. The 3-state outputs, B_0-B_7 , have been designed to prevent output bus loading if the power is removed from the device.

PIN CONFIGURATION



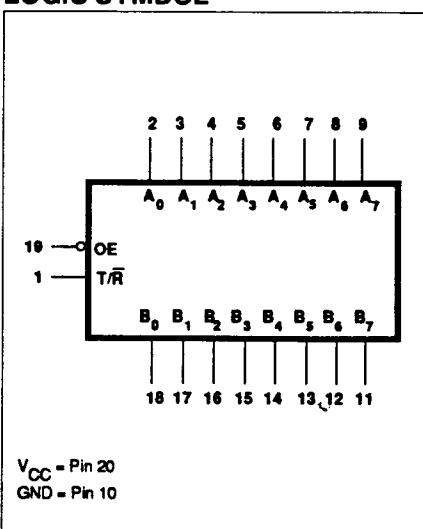
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
A_0-A_7 B_0-B_7	Data inputs	3.5/0.115	$70\mu A/70\mu A$
\overline{OE}	Output enable input (active Low)	2.0/0.067	$40\mu A/40\mu A$
T/R	Transmit/Receive input	2.0/0.067	$40\mu A/40\mu A$
A_0-A_7	A port outputs	150/40	$3.0mA/24mA$
B_0-B_7	B Port outputs	750/106.7	$15mA/64mA$

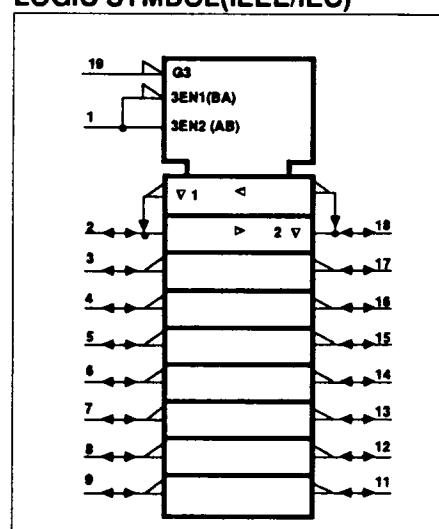
NOTE:

One (1.0) FAST Unit Load is defined as: $20\mu A$ in the High state and $0.6mA$ in the Low state.

LOGIC SYMBOL



LOGIC SYMBOL(IEEE/IEC)



Transceiver

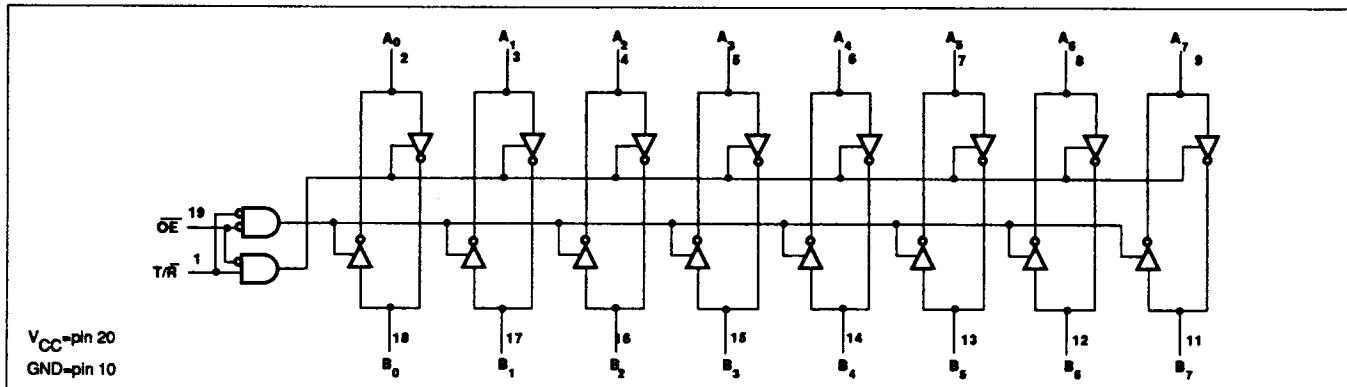
FAST 74F640

FUNCTION TABLE

INPUTS		OUTPUTS
\overline{OE}	T/R	
L	L	Bus B data to Bus A
L	H	Bus A data to Bus B
H	X	Z

H=High voltage level
L=Low voltage level
X=Don't care
Z=High impedance "off" state

LOGIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT	
V_{CC}	Supply voltage	-0.5 to +7.0	V	
V_{IN}	Input voltage	-0.5 to +7.0	V	
I_{IN}	Input current	-30 to +5	mA	
V_{OUT}	Voltage applied to output in High output state	-0.5 to + V_{CC}	V	
I_{OUT}	Current applied to output in Low output state	A_0 - A_7	48	mA
		B_0 - B_7	128	mA
T_A	Operating free-air temperature range	0 to +70	°C	
T_{STG}	Storage temperature	-65 to +150	°C	

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT	
		Min	Nom	Max		
V_{CC}	Supply voltage	4.5	5.0	5.5	V	
V_{IH}	High-level input voltage	2.0			V	
V_{IL}	Low-level input voltage			0.8	V	
I_{IK}	Input clamp current			-18	mA	
I_{OH}	High-level output current	A_0 - A_7			-3	mA
		B_0 - B_7			-15	mA
I_{OL}	Low-level output current	A_0 - A_7			24	mA
		B_0 - B_7			64	mA
T_A	Operating free-air temperature range	0		70	°C	

Transceiver

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DC ELECTRICAL CHARACTERISTICS (Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS ¹			LIMITS			UNIT	
					Min	Typ ²	Max		
V_{OH}	High-level output voltage	A_0-A_7 B_0-B_7	$V_{CC} = \text{MIN}$, $V_{IL} = \text{MAX}$, $V_{IH} = \text{MIN}$	$I_{OH} = -3\text{mA}$	$\pm 10\%V_{CC}$	2.4		V	
				$I_{OH} = -15\text{mA}$	$\pm 5\%V_{CC}$	2.7	3.3	V	
		B_0-B_7		$I_{OH} = -3\text{mA}$	$\pm 10\%V_{CC}$	2.0		V	
				$I_{OH} = -15\text{mA}$	$\pm 5\%V_{CC}$	2.0		V	
V_{OL}	Low-level output voltage	A_0-A_7	$V_{CC} = \text{MIN}$, $V_{IL} = \text{MAX}$, $V_{IH} = \text{MIN}$	$I_{OL} = 24\text{mA}$	$\pm 10\%V_{CC}$		0.35	V	
				$I_{OL} = 24\text{mA}$	$\pm 5\%V_{CC}$		0.35	V	
		B_0-B_7		$I_{OL} = \text{MAX}$	$\pm 10\%V_{CC}$		0.55	V	
				$I_{OL} = \text{MAX}$	$\pm 5\%V_{CC}$		0.42	V	
V_{IK}	Input clamp voltage		$V_{CC} = \text{MIN}$, $I_I = I_{IK}$			-0.73	-1.2	V	
I_I	Input current at maximum input voltage	$\overline{OE}, T/\bar{R}$	$V_{CC} = 0.0V, V_I = 7.0V$				100	μA	
		A_0-A_7, B_0-B_7	$V_{CC} = 5.5V, V_I = 5.5V$				1.0	mA	
I_{IH}	High-level input current	$\overline{OE}, T/\bar{R}$ only	$V_{CC} = \text{MAX}$, $V_I = 2.7V$				40	μA	
I_{IL}	Low-level input current		$V_{CC} = \text{MAX}$, $V_I = 0.5V$				-40	μA	
$I_{OZH} + I_{IH}$	Off state output current, High-level voltage applied		$V_{CC} = \text{MAX}$, $V_I = 2.7V$				70	μA	
$I_{OZL} + I_{IL}$	Off state output current, Low-level voltage applied		$V_{CC} = \text{MAX}$, $V_I = 0.5V$				-70	μA	
I_{OS}	Short circuit output current ³	A_0-A_7	$V_{CC} = \text{MAX}$		-60		-150	mA	
		B_0-B_7			-100		-225	μA	
I_{CC}	Supply current (total)	I_{CCH}	$V_{CC} = \text{MAX}$	$T/\bar{R}=A_n=4.5V, \overline{OE}=\text{GND}$		66	85	mA	
		I_{CCL}		$T/\bar{R}=B_n=\overline{OE}=\text{GND}$		91	120	mA	
		I_{CCZ}		$T/\bar{R}=B_n=\text{GND}, \overline{OE}=4.5V$		78	102	mA	

NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at $V_{CC} = 5V$, $T_A = 25^\circ C$.
- Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

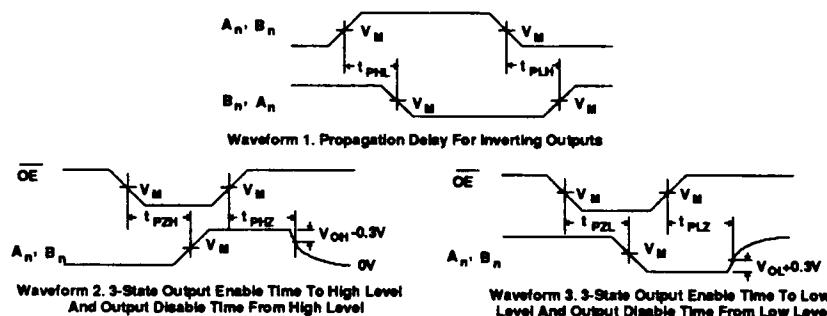
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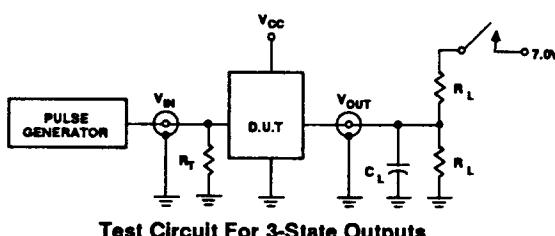
AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	LIMITS					UNIT
			$T_A = +25^\circ\text{C}$			$T_A = 0^\circ\text{C to } +70^\circ\text{C}$		
			$V_{CC} = 5\text{V}$	$C_L = 50\text{pF}$	$R_L = 500\Omega$	$V_{CC} = 5\text{V} \pm 10\%$	$C_L = 50\text{pF}$	$R_L = 500\Omega$
t_{PLH}	Propagation delay A_n to B_n , B_n to A_n	Waveform 1	2.0 1.0	4.5 2.5	7.0 5.0	2.0 1.0	8.0 5.5	ns
t_{PZH}	Output Enable time to High or Low level	Waveform 2 Waveform 3	5.5 5.5	6.5 7.0	10.5 10.5	5.0 5.0	12.0 11.0	ns
t_{PHZ}	Output Disable time from High or Low level	Waveform 2 Waveform 3	2.0 2.0	3.5 4.5	6.5 7.0	1.5 2.0	8.0 7.5	ns

AC WAVEFORMS

NOTE: For all waveforms, $V_M = 1.5\text{V}$.

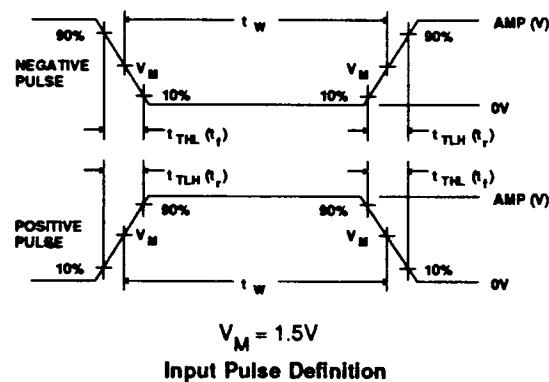
TEST CIRCUIT AND WAVEFORMS



SWITCH POSITION

TEST	SWITCH
t_{PLZ}	closed
t_{PZH}	closed
All other	open

DEFINITIONS

 R_L = Load resistor; see AC CHARACTERISTICS for value. C_L = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value. R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

FAMILY	INPUT PULSE REQUIREMENTS				
	Amplitude	Rep. Rate	t_W	t_{TLH}	t_{THL}
74F	3.0V	1MHz	500ns	2.5ns	2.5ns